


<b>Search Notes</b>  	<b>Application/Control No.</b>  10709179	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  Nathan W Ha	<b>Art Unit</b>  2814

SEARCHED			
Class	Subclass	Date	Examiner
257	686,777,734	12/9/07	nh

SEARCH NOTES		
Search Notes	Date	Examiner
see att.	12/9/07	nh

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner